

# Search Notes



Application/Control No.

10/825,781

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

CHIEN ET AL.

Art Unit

2817

## SEARCHED

Class	Subclass	Date	Examiner
330	~59	3/1/06	
"	~58	"	
"	9	"	
"	~52	3/2/06	
3~7	307	"	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Tulsh (East) see attachment	3/2/06	4-.
NPL (IEEE) see attachment	"	"